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FDMC008N08C

N-Channel Shielded Gate PowerTrench® MOSFET 80 V, 60 A, 7.8 mΩ

Features

- Shielded Gate MOSFET Technology
- Max $r_{DS(on)}$ = 7.8 mΩ at $V_{GS} = 10$ V, $I_D = 21$ A
- Max $r_{DS(on)}$ = 19.3 mΩ at $V_{GS} = 6$ V, $I_D = 10$ A
- 50% lower Qrr than other MOSFET suppliers
- Lowers switching noise/EMI
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

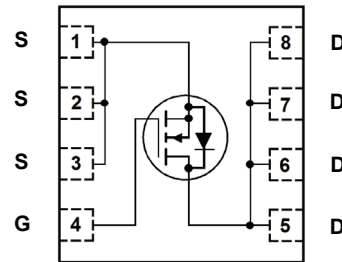
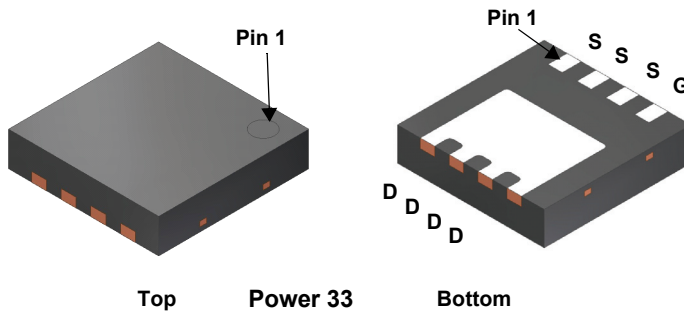


General Description

This N-Channel MV MOSFET is produced using ON Semiconductor's advanced PowerTrench® process that incorporates Shielded Gate technology. This process has been optimized to minimise on-state resistance and yet maintain superior switching performance with best in class soft body diode.

Applications

- Primary DC-DC MOSFET
- Synchronous Rectifier in DC-DC and AC-DC
- Motor Drive
- Solar



MOSFET Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted.

Symbol	Parameter	Ratings	Units
V_{DS}	Drain to Source Voltage	80	V
V_{GS}	Gate to Source Voltage	± 20	V
I_D	Drain Current -Continuous	$T_C = 25^\circ\text{C}$ (Note 5)	60
	-Continuous	$T_C = 100^\circ\text{C}$ (Note 5)	38
	-Continuous	$T_A = 25^\circ\text{C}$ (Note 1a)	12
	-Pulsed	(Note 4)	273
E_{AS}	Single Pulse Avalanche Energy	(Note 3)	150
P_D	Power Dissipation	$T_C = 25^\circ\text{C}$	57
	Power Dissipation	$T_A = 25^\circ\text{C}$ (Note 1a)	2.3
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ\text{C}$

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	2.2	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
008N08C	FDMC008N08C	Power 33	13 "	12 mm	3000 units

Electrical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
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Off Characteristics

BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\text{ }\mu\text{A}$, $V_{GS} = 0\text{ V}$	80			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\text{ }\mu\text{A}$, referenced to $25\text{ }^\circ\text{C}$		51		mV/ $^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 64\text{ V}$, $V_{GS} = 0\text{ V}$			1	μA
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20\text{ V}$, $V_{DS} = 0\text{ V}$			100	nA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 120\text{ }\mu\text{A}$	2.0	3.0	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 120\text{ }\mu\text{A}$, referenced to $25\text{ }^\circ\text{C}$		-8.4		mV/ $^\circ\text{C}$
$r_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{ V}$, $I_D = 21\text{ A}$		6.3	7.8	m Ω
		$V_{GS} = 6\text{ V}$, $I_D = 10\text{ A}$		9.6	19.3	
		$V_{GS} = 10\text{ V}$, $I_D = 21\text{ A}$, $T_J = 125\text{ }^\circ\text{C}$		10.7	13.5	
g_{FS}	Forward Transconductance	$V_{DS} = 5\text{ V}$, $I_D = 21\text{ A}$		50		S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 40\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$		1535	2150	pF
C_{oss}	Output Capacitance			517	730	pF
C_{rss}	Reverse Transfer Capacitance			19	30	pF
R_g	Gate Resistance		0.1	0.4	0.8	Ω

Switching Characteristics

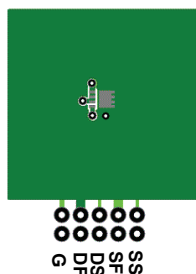
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 40\text{ V}$, $I_D = 21\text{ A}$, $V_{GS} = 10\text{ V}$, $R_{GEN} = 6\text{ }\Omega$		12	22	ns
t_r	Rise Time			3	10	ns
$t_{d(off)}$	Turn-Off Delay Time			18	32	ns
t_f	Fall Time			3	10	ns
Q_g	Total Gate Charge		$V_{GS} = 0\text{ V to }10\text{ V}$	21	29	nC
Q_g	Total Gate Charge	$V_{GS} = 0\text{ V to }6\text{ V}$	13	18	nC	
Q_{gs}	Gate to Source Charge	$V_{DD} = 40\text{ V}$, $I_D = 21\text{ A}$		6.7		nC
Q_{gd}	Gate to Drain "Miller" Charge			3.8		nC
Q_{oss}	Output Charge		$V_{DD} = 40\text{ V}$, $V_{GS} = 0\text{ V}$		28	
Q_{sync}	Total Gate Charge Sync.	$V_{DS} = 0\text{ V}$, $I_D = 21\text{ A}$		18		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{ V}$, $I_S = 2\text{ A}$ (Note 2)		0.7	1.2	V
		$V_{GS} = 0\text{ V}$, $I_S = 21\text{ A}$ (Note 2)		0.8	1.3	
t_{rr}	Reverse Recovery Time	$I_F = 10\text{ A}$, $di/dt = 300\text{ A}/\mu\text{s}$		19	30	ns
Q_{rr}	Reverse Recovery Charge			27	44	nC
t_{rr}	Reverse Recovery Time	$I_F = 10\text{ A}$, $di/dt = 1000\text{ A}/\mu\text{s}$		15	23	ns
Q_{rr}	Reverse Recovery Charge			65	105	nC

Notes:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 pad 2 oz copper pad on a $1.5 \times 1.5\text{ in.}$ board of FR-4 material. $R_{\theta CA}$ is determined by the user's board design.



a. $53\text{ }^\circ\text{C/W}$ when mounted on a 1 in^2 pad of 2 oz copper



b. $125\text{ }^\circ\text{C/W}$ when mounted on a minimum pad of 2 oz copper

2. Pulse Test: Pulse Width $< 300\text{ }\mu\text{s}$, Duty cycle $< 2.0\%$.

3. E_{AS} of 150 mJ is based on starting $T_J = 25\text{ }^\circ\text{C}$, $L = 3\text{ mH}$, $I_{AS} = 10\text{ A}$, $V_{DD} = 10\text{ V}$, $V_{GS} = 80\text{ V}$, 100% test at $L = 0.1\text{ mH}$, $I_{AS} = 33\text{ A}$.

4. Pulsed I_d please refer to Fig 11 SOA graph for more details.

5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

Typical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted.

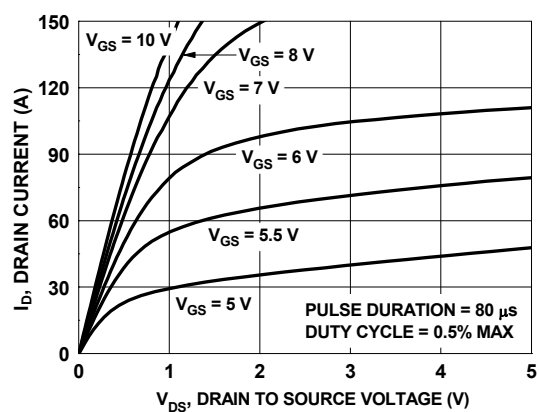


Figure 1. On Region Characteristics

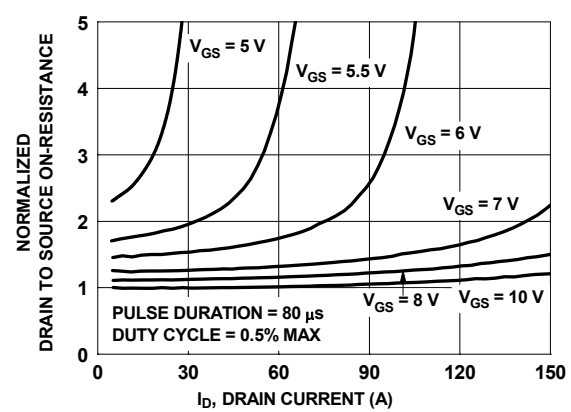


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

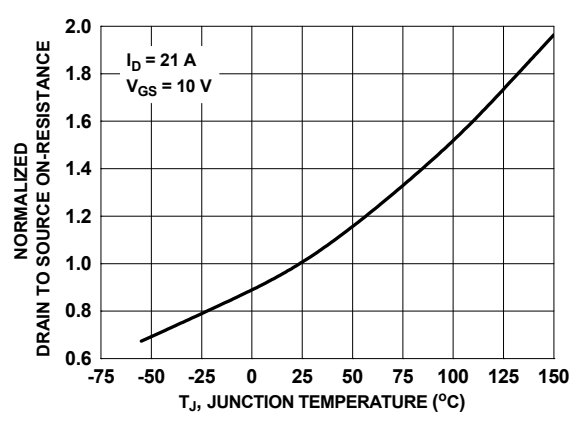


Figure 3. Normalized On Resistance vs. Junction Temperature

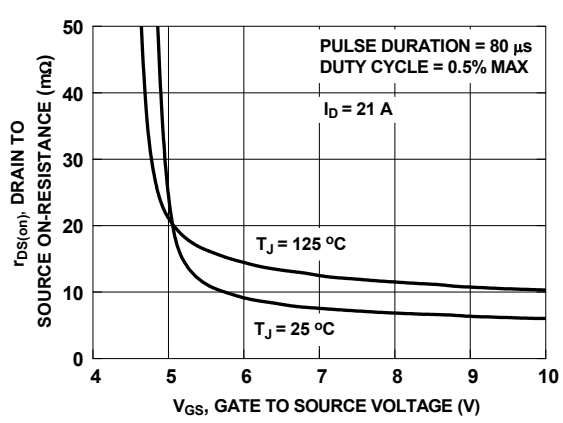


Figure 4. On-Resistance vs. Gate to Source Voltage

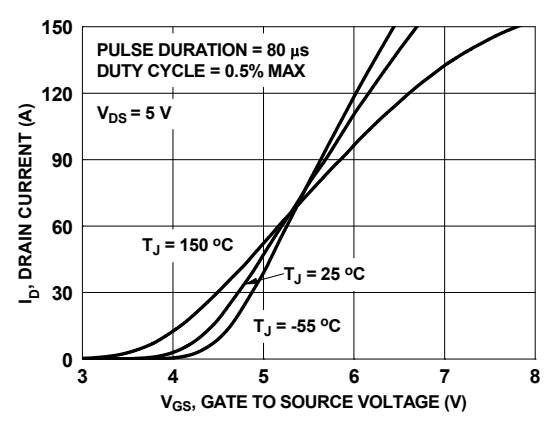


Figure 5. Transfer Characteristics

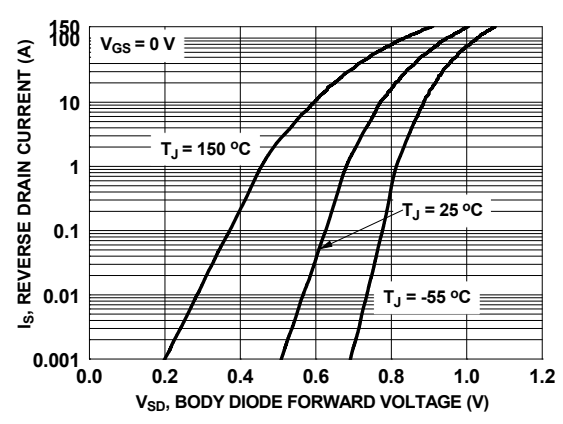


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted.

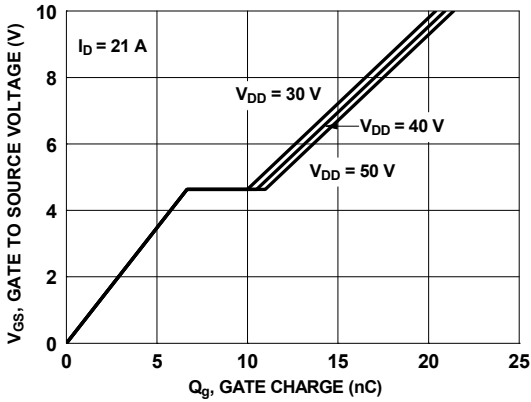


Figure 7. Gate Charge Characteristics

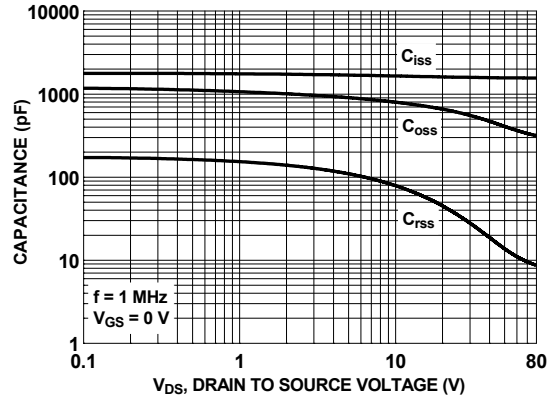


Figure 8. Capacitance vs. Drain to Source Voltage

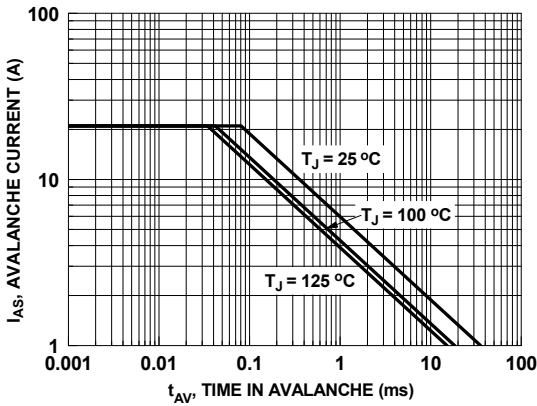


Figure 9. Unclamped Inductive Switching Capability

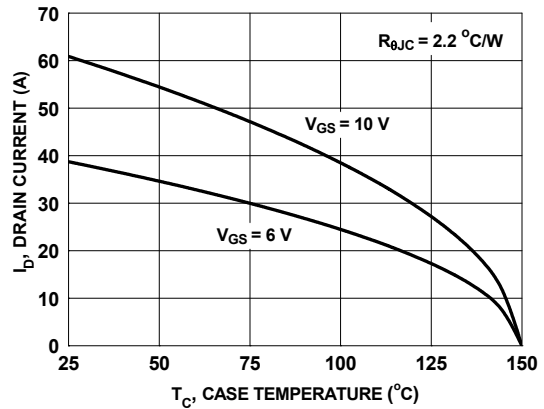


Figure 10. Maximum Continuous Drain Current vs Case Temperature

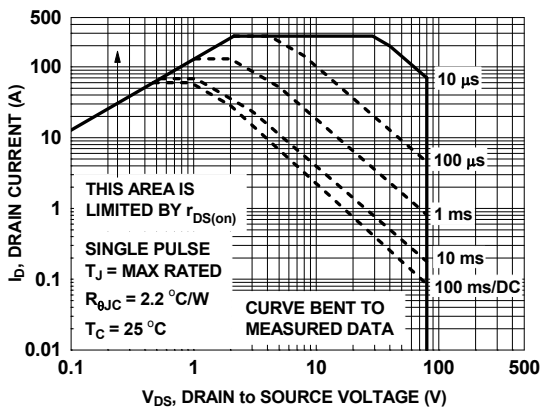


Figure 11. Forward Bias Safe Operating Area

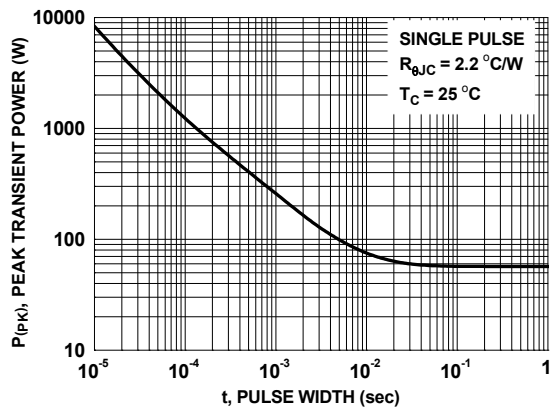


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted.

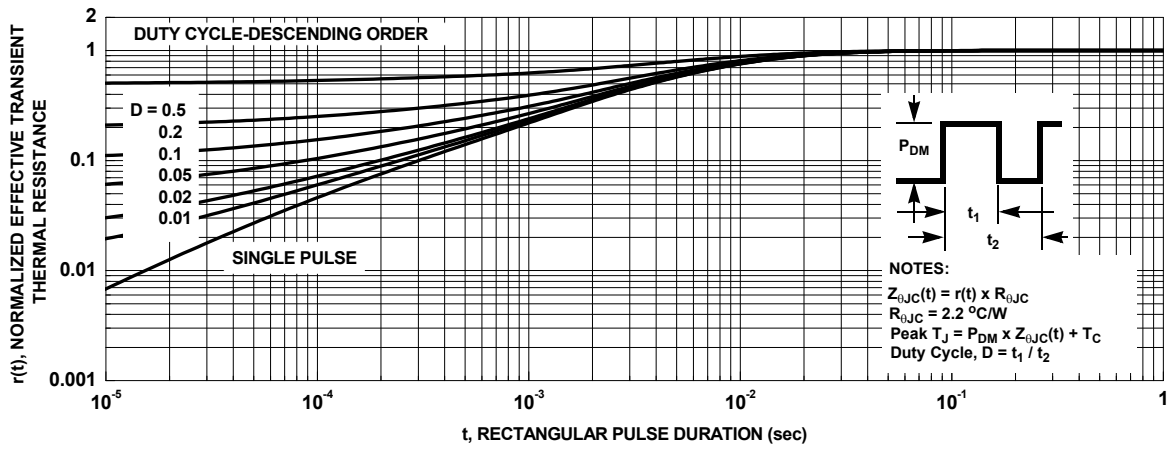
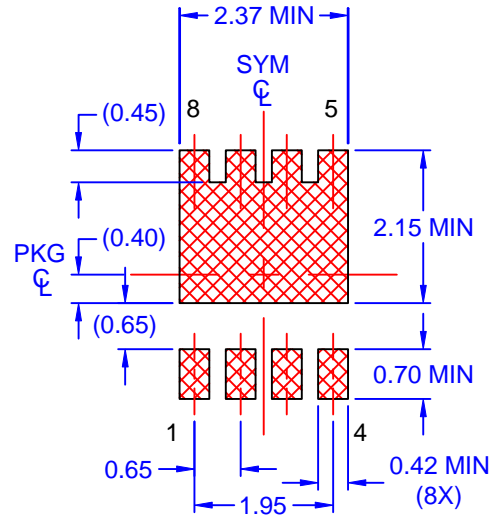
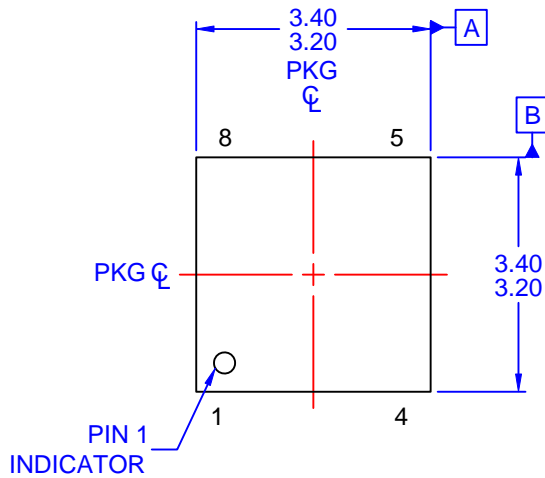
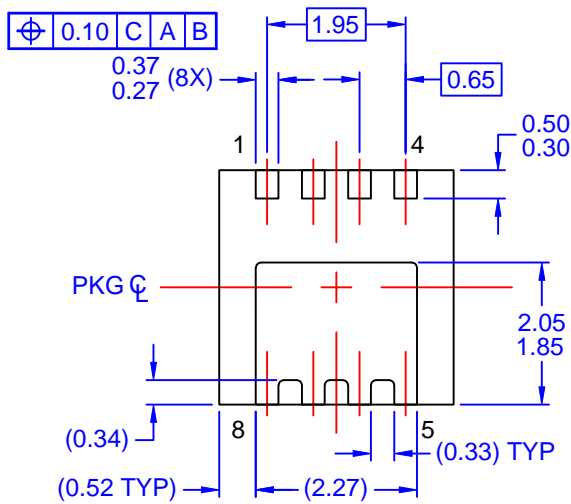
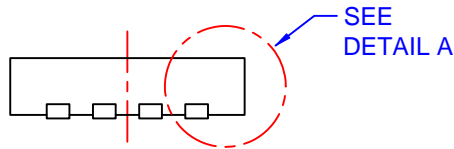


Figure 13. Junction-to-Case Transient Thermal Response Curve

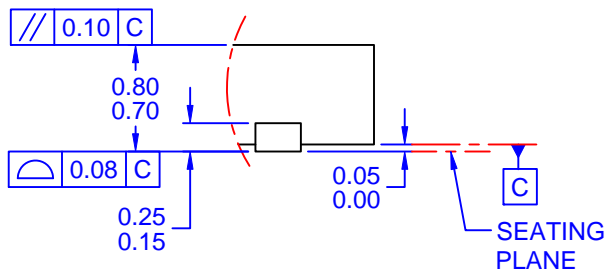


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NOTES: UNLESS OTHERWISE SPECIFIED

- A) PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. BA, DATED OCTOBER 2002.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- E) DRAWING FILE NAME: PQFN08HREV1



DETAIL A
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